

## SKM400GA12V



SEMITRANS® 4

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## Features

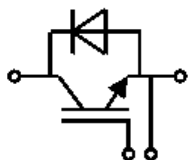
- V-IGBT = 6. Generation Trench V-IGBT (Fuji)
- CAL4 = Soft switching 4. Generation CAL-diode
- Isolated copper baseplate using DBC technology (Direct Copper Bonding)
- UL recognized, file no. E63532
- Increased power cycling capability
- With integrated gate resistor
- Low switching losses at high di/dt

## Typical Applications\*

- AC inverter drives
- UPS
- Electronic welders
- Switched reluctance motor

## Remarks

- Case temperature limited to  $T_c = 125^\circ\text{C}$  max, recomm.  $T_{op} = -40 \dots +150^\circ\text{C}$ , product rel. results valid for  $T_j = 150^\circ$



GA

| Absolute Maximum Ratings |                                                                                |                         |             |      |
|--------------------------|--------------------------------------------------------------------------------|-------------------------|-------------|------|
| Symbol                   | Conditions                                                                     |                         | Values      | Unit |
| IGBT                     |                                                                                |                         |             |      |
| V <sub>CES</sub>         | T <sub>j</sub> = 25 °C                                                         |                         | 1200        | V    |
| I <sub>C</sub>           | T <sub>j</sub> = 175 °C                                                        | T <sub>c</sub> = 25 °C  | 612         | A    |
|                          |                                                                                | T <sub>c</sub> = 80 °C  | 467         | A    |
| I <sub>Cnom</sub>        |                                                                                |                         | 400         | A    |
| I <sub>CRM</sub>         | I <sub>CRM</sub> = 3xI <sub>Cnom</sub>                                         |                         | 1200        | A    |
| V <sub>GES</sub>         |                                                                                |                         | -20 ... 20  | V    |
| t <sub>psc</sub>         | V <sub>CC</sub> = 720 V<br>V <sub>GE</sub> ≤ 15 V<br>V <sub>CES</sub> ≤ 1200 V | T <sub>j</sub> = 125 °C | 10          | μs   |
| T <sub>j</sub>           |                                                                                |                         | -40 ... 175 | °C   |
| Inverse diode            |                                                                                |                         |             |      |
| I <sub>F</sub>           | T <sub>j</sub> = 175 °C                                                        | T <sub>c</sub> = 25 °C  | 440         | A    |
|                          |                                                                                | T <sub>c</sub> = 80 °C  | 329         | A    |
| I <sub>Fnom</sub>        |                                                                                |                         | 400         | A    |
| I <sub>FRM</sub>         | I <sub>FRM</sub> = 3xI <sub>Fnom</sub>                                         |                         | 1200        | A    |
| I <sub>FSM</sub>         | t <sub>p</sub> = 10 ms, sin 180°, T <sub>j</sub> = 25 °C                       |                         | 1980        | A    |
| T <sub>j</sub>           |                                                                                |                         | -40 ... 175 | °C   |
| Module                   |                                                                                |                         |             |      |
| I <sub>t(RMS)</sub>      | T <sub>terminal</sub> = 80 °C                                                  |                         | 500         | A    |
| T <sub>stg</sub>         |                                                                                |                         | -40 ... 125 | °C   |
| V <sub>isol</sub>        | AC sinus 50 Hz, t = 1 min                                                      |                         | 4000        | V    |

| Characteristics      |                                                                                                         |                         |                         |       |       |      |
|----------------------|---------------------------------------------------------------------------------------------------------|-------------------------|-------------------------|-------|-------|------|
| Symbol               | Conditions                                                                                              |                         | min.                    | typ.  | max.  | Unit |
| IGBT                 |                                                                                                         |                         |                         |       |       |      |
| V <sub>CE(sat)</sub> | I <sub>C</sub> = 400 A                                                                                  | T <sub>j</sub> = 25 °C  |                         | 1.75  | 2.20  | V    |
|                      | V <sub>GE</sub> = 15 V<br>chipelevel                                                                    | T <sub>j</sub> = 150 °C |                         | 2.20  | 2.50  | V    |
| V <sub>CE0</sub>     | chipelevel                                                                                              | T <sub>j</sub> = 25 °C  |                         | 0.94  | 1.04  | V    |
|                      |                                                                                                         | T <sub>j</sub> = 150 °C |                         | 0.88  | 0.98  | V    |
| r <sub>CE</sub>      | V <sub>GE</sub> = 15 V<br>chipelevel                                                                    | T <sub>j</sub> = 25 °C  |                         | 2.02  | 2.90  | mΩ   |
|                      |                                                                                                         | T <sub>j</sub> = 150 °C |                         | 3.30  | 3.80  | mΩ   |
| V <sub>GE(th)</sub>  | V <sub>GE</sub> =V <sub>CE</sub> , I <sub>C</sub> = 16 mA                                               |                         | 5.5                     | 6     | 6.5   | V    |
| I <sub>CES</sub>     | V <sub>GE</sub> = 0 V                                                                                   | T <sub>j</sub> = 25 °C  |                         | 0.1   | 0.3   | mA   |
|                      | V <sub>CE</sub> = 1200 V                                                                                | T <sub>j</sub> = 150 °C |                         |       |       | mA   |
| C <sub>ies</sub>     | V <sub>CE</sub> = 25 V<br>V <sub>GE</sub> = 0 V                                                         | f = 1 MHz               |                         | 24.04 |       | nF   |
| C <sub>oes</sub>     |                                                                                                         | f = 1 MHz               |                         | 2.36  |       | nF   |
| C <sub>res</sub>     |                                                                                                         | f = 1 MHz               |                         | 2.356 |       | nF   |
| Q <sub>G</sub>       | V <sub>GE</sub> = - 8 V...+ 15 V                                                                        |                         |                         | 4420  |       | nC   |
| R <sub>Gint</sub>    |                                                                                                         |                         |                         | 1.88  |       | Ω    |
| t <sub>d(on)</sub>   | V <sub>CC</sub> = 600 V                                                                                 | T <sub>j</sub> = 150 °C |                         | 350   |       | ns   |
| t <sub>r</sub>       | I <sub>C</sub> = 400 A                                                                                  |                         | T <sub>j</sub> = 150 °C |       | 60    |      |
| E <sub>on</sub>      | V <sub>GE</sub> = ±15 V                                                                                 | T <sub>j</sub> = 150 °C |                         | 39    |       | mJ   |
| t <sub>d(off)</sub>  | R <sub>G on</sub> = 3 Ω                                                                                 | T <sub>j</sub> = 150 °C |                         | 700   |       | ns   |
| t <sub>f</sub>       | R <sub>G off</sub> = 3 Ω                                                                                | T <sub>j</sub> = 150 °C |                         | 65    |       | ns   |
| E <sub>off</sub>     | di/dt <sub>on</sub> = 9800 A/μs<br>di/dt <sub>off</sub> = 5000 A/μs<br>du/dt <sub>off</sub> = 7600 V/μs | T <sub>j</sub> = 150 °C |                         | 42    |       | mJ   |
| R <sub>th(j-c)</sub> | per IGBT                                                                                                |                         |                         |       | 0.072 | K/W  |



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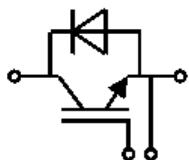
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### Remarks

- Case temperature limited to  $T_c = 125^\circ\text{C}$  max, recomm.
- $T_{op} = -40 \dots +150^\circ\text{C}$ , product rel. results valid for  $T_j = 150^\circ$

| Characteristics                  |                                                    |                         |      |      |       |      |
|----------------------------------|----------------------------------------------------|-------------------------|------|------|-------|------|
| Symbol                           | Conditions                                         |                         | min. | typ. | max.  | Unit |
| Inverse diode                    |                                                    |                         |      |      |       |      |
| V <sub>F</sub> = V <sub>EC</sub> | I <sub>F</sub> = 400 A                             | T <sub>j</sub> = 25 °C  |      | 2.20 | 2.52  | V    |
|                                  | V <sub>GE</sub> = 0 V<br>chiplevel                 | T <sub>j</sub> = 150 °C |      | 2.15 | 2.47  | V    |
| V <sub>F0</sub>                  | chiplevel                                          | T <sub>j</sub> = 25 °C  |      | 1.3  | 1.5   | V    |
|                                  |                                                    | T <sub>j</sub> = 150 °C |      | 0.9  | 1.1   | V    |
| r <sub>F</sub>                   | chiplevel                                          | T <sub>j</sub> = 25 °C  |      | 2.3  | 2.5   | mΩ   |
|                                  |                                                    | T <sub>j</sub> = 150 °C |      | 3.1  | 3.4   | mΩ   |
| I <sub>RRM</sub>                 | I <sub>F</sub> = 400 A                             | T <sub>j</sub> = 150 °C |      | 450  |       | A    |
| Q <sub>rr</sub>                  | di/dt <sub>off</sub> = 9500 A/μs                   | T <sub>j</sub> = 150 °C |      | 58   |       | μC   |
| E <sub>rr</sub>                  | V <sub>GE</sub> = ±15 V<br>V <sub>CC</sub> = 600 V | T <sub>j</sub> = 150 °C |      | 26   |       | mJ   |
| R <sub>th(j-c)</sub>             | per diode                                          |                         |      |      | 0.14  | K/W  |
| Module                           |                                                    |                         |      |      |       |      |
| L <sub>CE</sub>                  |                                                    |                         |      | 15   | 20    | nH   |
| R <sub>CC'+EE'</sub>             | terminal-chip                                      | T <sub>C</sub> = 25 °C  |      | 0.18 |       | mΩ   |
|                                  |                                                    | T <sub>C</sub> = 125 °C |      | 0.22 |       | mΩ   |
| R <sub>th(c-s)</sub>             | per module                                         |                         |      | 0.02 | 0.038 | K/W  |
| M <sub>s</sub>                   | to heat sink M6                                    |                         | 3    |      | 5     | Nm   |
| M <sub>t</sub>                   | to terminals                                       | M6                      | 2.5  |      | 5     | Nm   |
|                                  |                                                    | M4                      | 1.1  |      | 2     | Nm   |
| w                                |                                                    |                         |      |      | 330   | g    |



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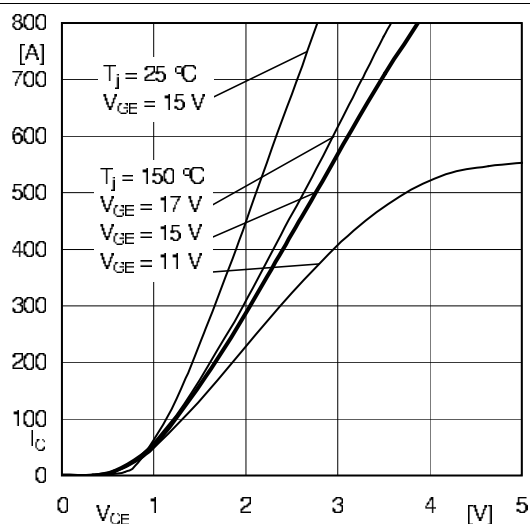


Fig. 1: Typ. output characteristic, inclusive  $R_{CC'+EE'}$

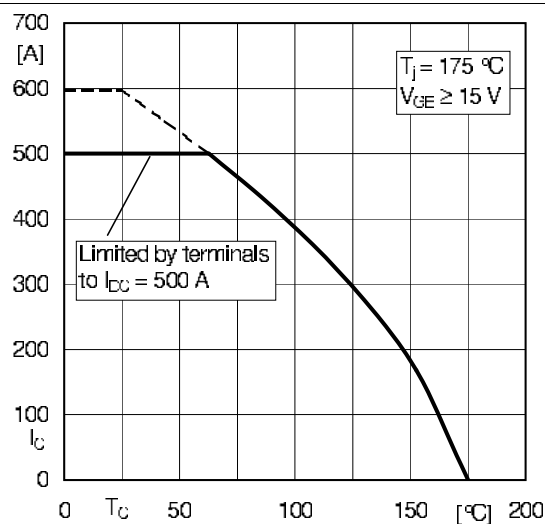


Fig. 2: Rated current vs. temperature  $I_C = f(T_C)$

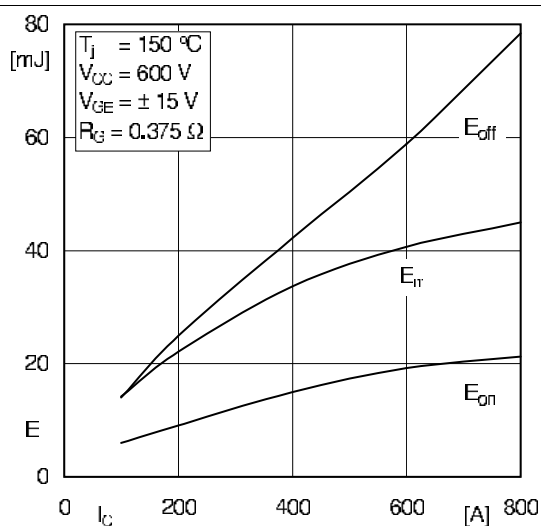


Fig. 3: Typ. turn-on /-off energy =  $f(I_C)$

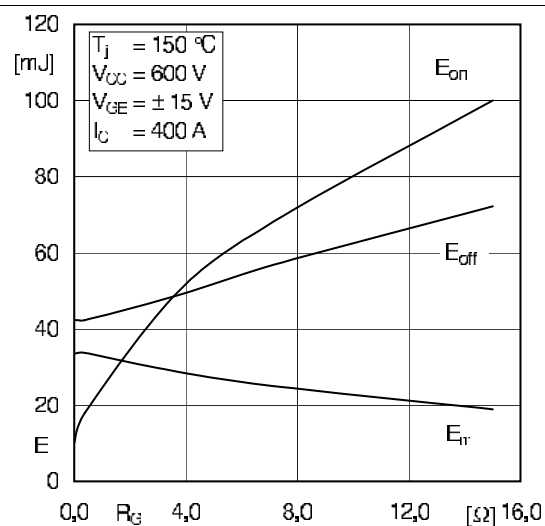


Fig. 4: Typ. turn-on /-off energy =  $f(R_G)$

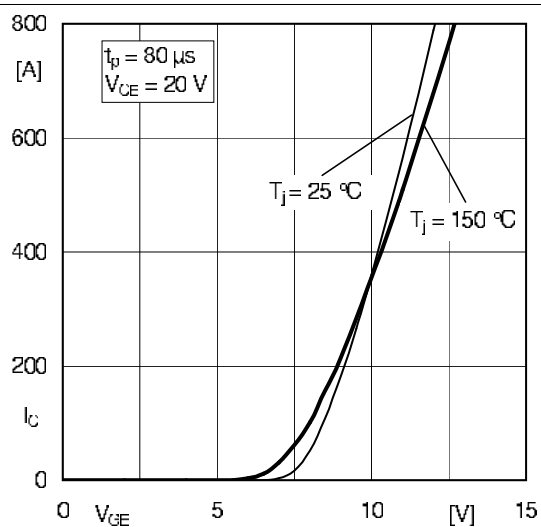


Fig. 5: Typ. transfer characteristic

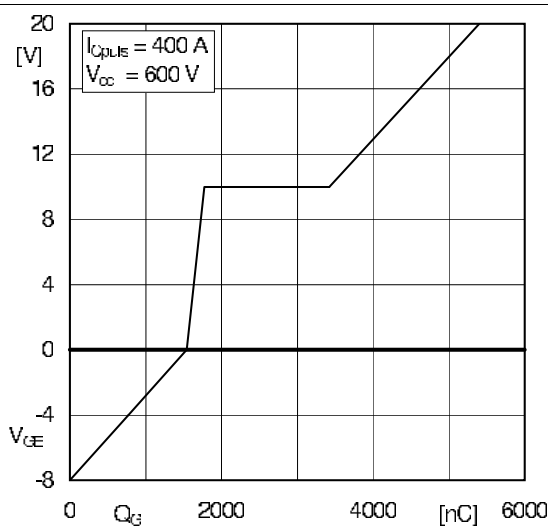


Fig. 6: Typ. gate charge characteristic

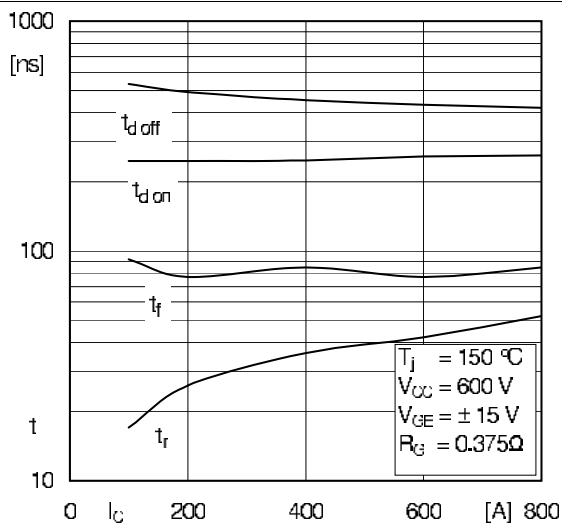


Fig. 7: Typ. switching times vs.  $I_C$

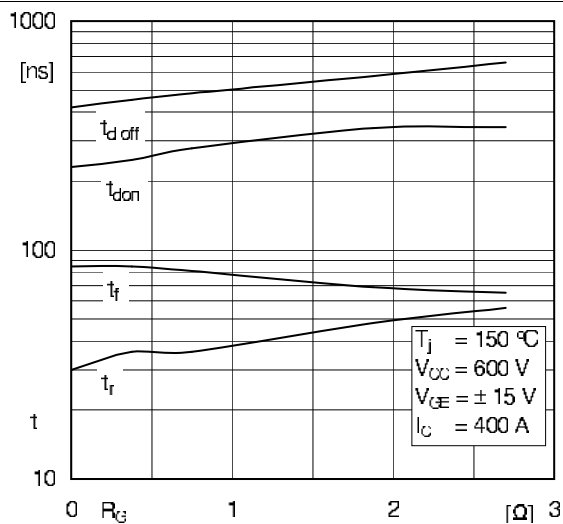


Fig. 8: Typ. switching times vs. gate resistor  $R_G$

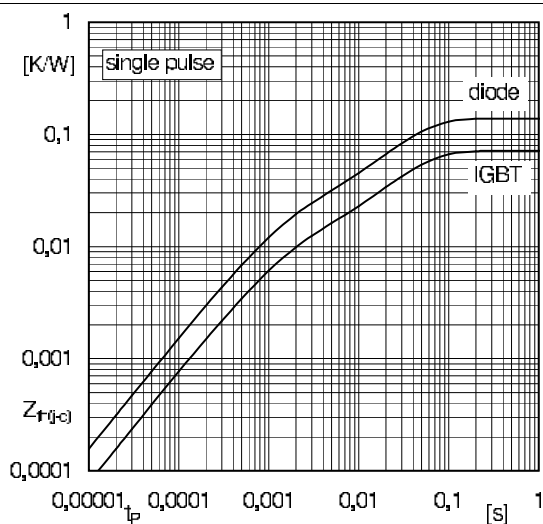


Fig. 9: Transient thermal impedance

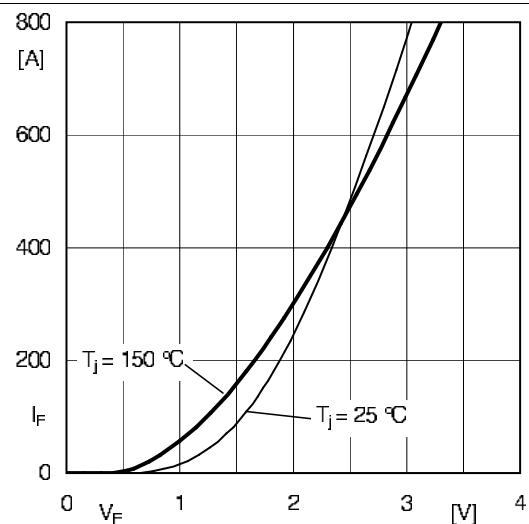


Fig. 10: Typ. CAL diode forward charact., incl.  $R_{CC'}+EE'$

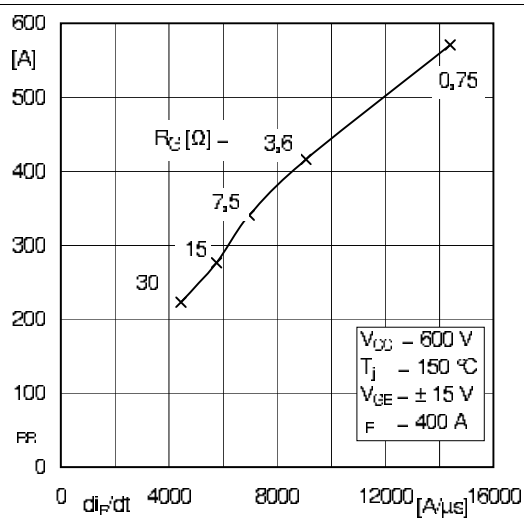


Fig. 11: CAL diode peak reverse recovery current

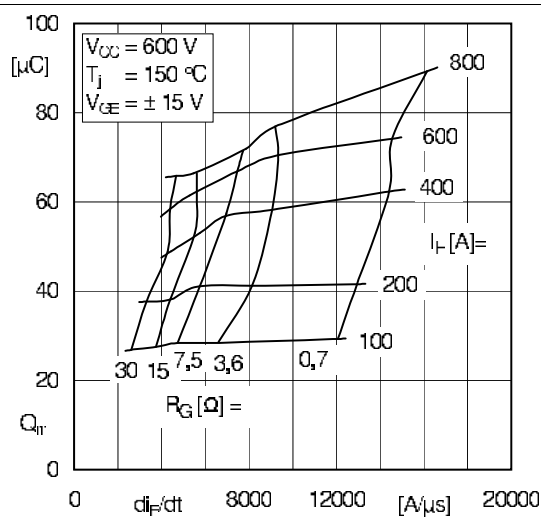


Fig. 12: Typ. CAL diode peak reverse recovery charge

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\* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our staff.